

FDS6814

Dual N-Channel 2.5V Specified PowerTrench™ MOSFET

General Description

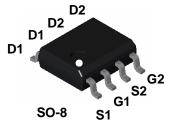
These N-Channel 2.5V specified MOSFETs are produced using a rugged gate version of Fairchild's advanced PowerTrench™ process. It has been optimized for power management applications which require a wide range of gate drive voltage.

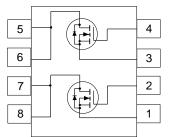
Applications

- Low voltage DC/DC Converters
- · Load switch
- · Battery protection
- · Power management

Features

- 8 A, 20 V. $R_{DS(ON)} = 0.020 \Omega @ V_{GS} = 4.5 V$ $R_{DS(ON)} = 0.030 \Omega @ V_{GS} = 2.5 V$
- Rugged gate rating (±12V).
- · Low gate charge.
- · Fast switching speed.
- · High performance trench technology for extremely low $R_{DS(ON)}$.
- · High power and current handling capability.





Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		±12	V
I _D	Drain Current - Continuous	(Note 1a)	8	A
	- Pulsed		50	
P _D	Power Dissipation for Dual Operation		2.0	W
	Power Dissipation for Single Operation	(Note 1a)	1.6	
		(Note 1b)	1.0	
		(Note 1c)	0.9	
T _J , T _{stg}	Operating and Storage Junction Temperat	ure Range	-55 to +150	°C

Thermal Characteristics

R _e JA	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
R _e JC	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

Package Marking and Ordering Information

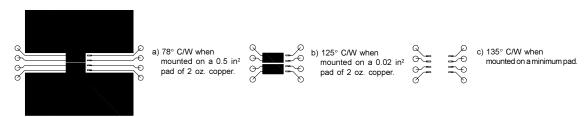
_	· acitage maritim	g and cracini	<u>g</u>			
	Device Marking Device		Reel Size	Tape width	Quantity	
	FDS6814	FDS6814	13"	12mm	2500 units	

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Electrical Characteristics T _A =25°C unless otherwise noted									
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units			
OFF CH	ARACTERISTICS								
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	20			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V			1	μΑ			
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = 12 V, V _{DS} = 0 V			100	nA			
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -12 V, V _{DS} = 0 V			-100	nA			
ON CHA	RACTERISTICS (Note 2) Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	0.6		1.5	V			
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$ $V_{GS} = 2.5 \text{ V}, I_D = 6.5 \text{ A}$			0.02 0.03	Ω			
I _{D(ON)}	On-State Drain Current	V _{GS} = 4.5 V, V _{DS} = 5.0 V	25			Α			
DRAIN-S	SOURCE DIODE CHARACTE Maximum Continuous Drain-Source	RISTICS AND MAXIMUM RA	TINGS 		1.3	A			
V _{SD}	Drain-Source Diode Forward	$V_{GS} = 0 \text{ V}, I_S = 1.3 \text{ A}$ (Note 2)			1.2	V			

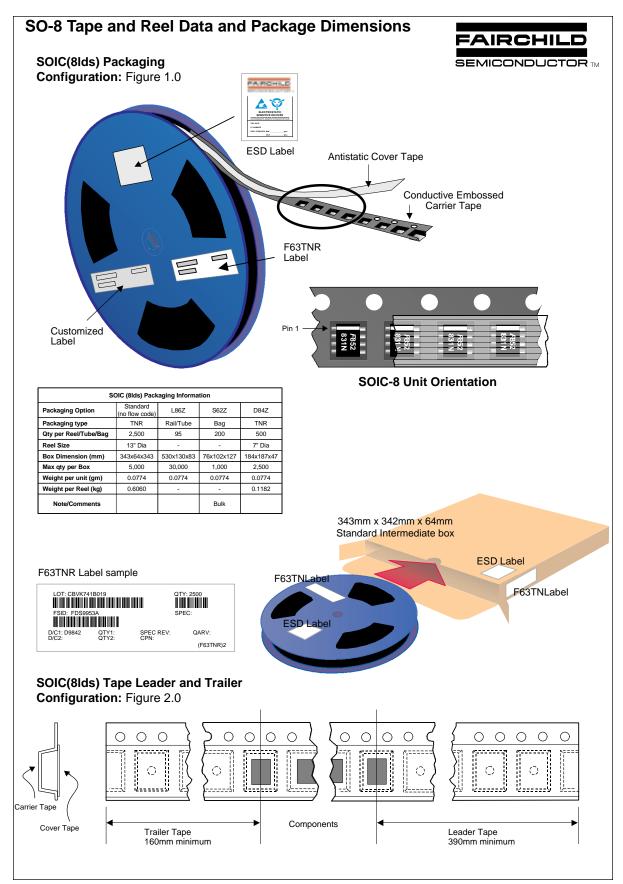
Notes:

R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.
 R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design. Thermal rating based on independent single device operation.



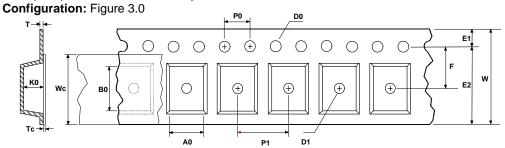
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width $\leq 300~\mu s,~Duty~Cycle \leq 2.0\%$





SOIC(8lds) Embossed Carrier Tape



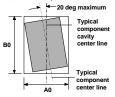
User Direction of Feed

	Dimensions are in millimeter													
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	K0	т	Wc	Тс
SOIC(8lds) (12mm)	6.50 +/-0.10	5.30 +/-0.10	12.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	10.25 min	5.50 +/-0.05	8.0 +/-0.1	4.0 +/-0.1	2.1 +/-0.10	0.450 +/- 0.150	9.2 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



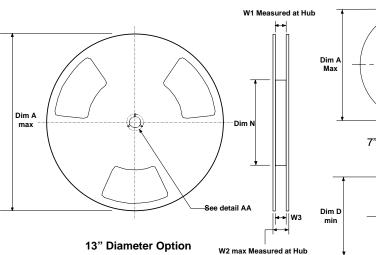
Sketch B (Top View)
Component Rotation

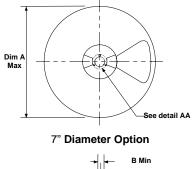


Sketch C (Top View)

Component lateral movement

SOIC(8lds) Reel Configuration: Figure 4.0



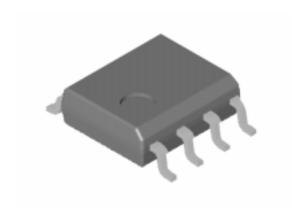


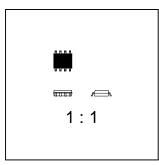
	7" Diameter Option
	→ B Min
Dim D min	Dim C

								DETAIL AA	L		
	Dimensions are in inches and millimeters										
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)		
12mm	7" Dia	7.00 177.8	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	5.906 150	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4		
12mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	7.00 178	0.488 +0.078/-0.000 12.4 +2/0	0.724 18.4	0.469 - 0.606 11.9 - 15.4		

SO-8 Tape and Reel Data and Package Dimensions, continued

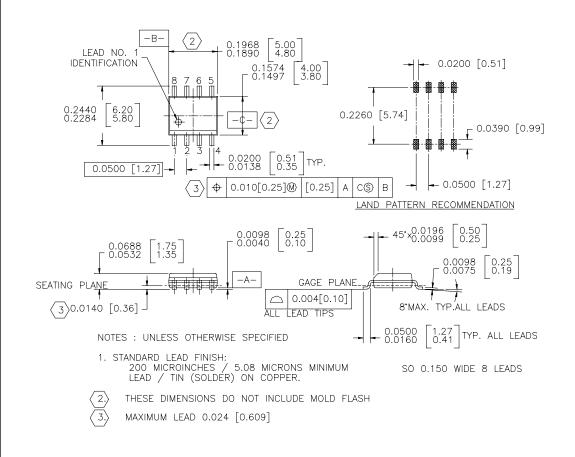
SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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